

$10\mu\text{m}$



A scanning electron micrograph (SEM) of a device structure. The image shows a central horizontal band of a textured, greyish material, likely a semiconductor or insulator, flanked by smoother, brownish regions. A vertical line of a different material, possibly a metal contact, runs through the center of the textured band. A scale bar on the left indicates a length of 10 μm. A voltage bias of 15V is indicated on the right side of the image.

15V